SDLS090 - OCTOBER 1976 - REVISED MARCH 1988

- Contains Eight Flip-Flops With Single-Rail **Outputs**
- **Buffered Clock and Direct Clear Inputs**
- **Individual Data Input to Each Flip-Flop**
- **Applications Include:**

Buffer/Storage Registers Shift Registers Pattern Generators

description

These monolithic, positive-edge-triggered flipflops utilize TTL circuitry to implement D-type flip-flop logic with a direct clear input.

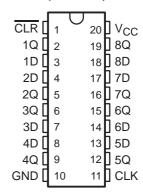
Information at the D inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock input is at either the high or low level, the D input signal has no effect ar the output.

These flip-flops are guaranteed to respond to clock frequencies ranging form 0 to 30 megahertz while maximum clock frequency is typically 40 megahertz. Typical power dissipation is 39 milliwatts per flip-flop for the '273 and 10 milliwatts for the 'LS273.

FUNCTION TABLE (each flip-flop)

ı	NPUTS		OUTPUT
CLEAR	CLOCK	D	Q
L	Х	Χ	L
Н	\uparrow	Н	Н
Н	\uparrow	L	L
Н	L	Χ	Q ₀

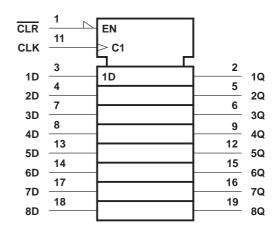
SN54273, SN74LS273 . . . J OR W PACKAGE SN74273...N PACKAGE SN74LS273...DW OR N PACKAGE (TOP VIEW)



SN54LS273 ... FK PACKAGE (TOP VIEW)



logic symbol[†]



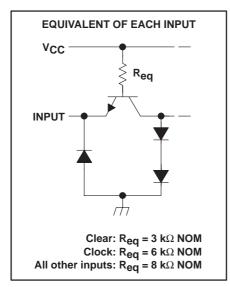
†This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

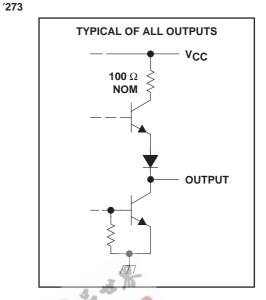
Pin numbers shown are for the DW, J, N, and W packages.

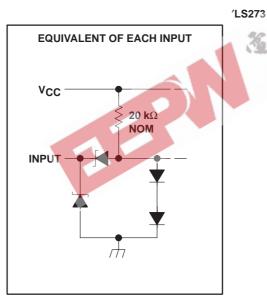


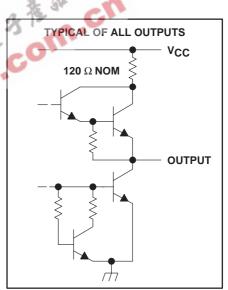
SDLS090 - OCTOBER 1976 - REVISED MARCH 1988

schematics of inputs and outputs

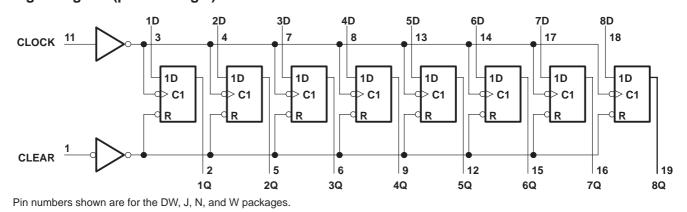








logic diagram (positive logic)





SDLS090 - OCTOBER 1976 - REVISED MARCH 1988

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature range, T _A : SN54273	-55°C to 125°C
SN74273	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54273			SN74273			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH				-800			-800	μΑ
Low-level output current, IOL				16			16	mA
Clock frequency, f _{clock}		0		30	0		30	MHz
Width of clock or clear pulse, t _W		16.5	an an		16.5			ns
Saturations t	Data input	20↑		20↑			20	
Setup time, t _{SU}	Clear inactive state	25↑	-		25↑			ns
Data hold time, th	- 9c	5↑	C		5↑			ns
Operating free-air temperature, T _A	4 (2)	-55		125	0		70	°C

[↑]The arrow indicates that the rising edge of the clock pulse is used for reference.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CO	TEST CONDITIONS†			MAX	UNIT
VIH	High-level input voltage				2			V
V _{IL}	Low-level input voltage						0.8	V
٧ıK	Input clamp voltage		$V_{CC} = MIN,$	I _I = –12 mA			-1.5	V
Vон	High-level output voltage		V _C C = MIN, V _{IL} = 0.8 V,	$V_{IH} = 2 V$, $I_{OH} = -800 \mu A$	2.4	3.4		V
VOL	Low-level output voltage		V _{CC} = MIN, V _{IL} = 0.8 V,	$V_{IH} = 2 V$, $I_{OH} = 16 \text{ mA}$			0.4	V
I _I	Input current at maximum input voltage		$V_{CC} = MAX$,	V _I = 5.5 V			1	mA
1	High-level input current	Clear	Voc – MAY	V _I = 2.4 V			80	μΑ
l IH	nigh-level input current	Clock or D	V _{CC} = MAX,	V = 2.4 V			40	μΑ
i	Low-level input current	Clear	V _{CC} = MAX,	V _I = 0.4 V			-3.2	mA
IIL.	Low-level input current	vCC = IVIAX,	V = 0.4 V			-1.6	IIIA	
los	IOS Short-circuit output current§		$V_{CC} = MAX$		-18		-57	mA
ICC	Supply current		$V_{CC} = MAX$,	See Note 2	·	62	94	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: With all outputs open and 4.5 V applied to all data and clear inputs, I_{CC} is measured after a momentary ground, then 4.5 V, is applied to clock.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] Not more than one output should be shorted at a time.

SDLS090 - OCTOBER 1976 - REVISED MARCH 1988

switching characteristics, V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
fmax	Maximum clock frequency	_	30	40		MHz
tPHL	Propagation delay time, high-to-low-level output from clear	$C_L = 15 \text{ pF},$ $R_1 = 400 \Omega,$		18	27	ns
tPLH	Propagation delay time, low-to-high-level output from clock	See Note 3		17	27	ns
tPHL	Propagation delay time, high-to-low-level output from clock			18	27	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)		 	 	. 7 V
Input voltage		 	 	. 7 V
Operating free-air temperature range, TA:	SN54LS273	 	 -55°C to	125°C
	SN74LS273	 	 0°C to	o 70°C
Storage temperature range		 	 -65°C to	150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	n 3	g. /**				
	SN	54LS2 73	SN74LS273		UNIT	
- %	MIN	NOM MAX	MIN	NOM	MAX	UNII
3	4.5	5 5.5	4.75	5	5.25	V
	0.	-400			-400	μΑ
		4			8	mA
	0	30	0		30	MHz
	20		20			ns
	20↑		20↑			20
state	20 20 n 20↑ 20↑ 25↑ 25↑	115				
	5↑		5↑			ns
·	-55	125	0		70	°C
	state	MIN 4.5 0 20 20↑ state 25↑ 5↑	4.5 5 5.5 -400 4 0 30 20 20↑ state 25↑ 5↑	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	MIN NOM MAX MIN NOM MAX 4.5 5 5.5 4.75 5 5.25 -400 -400 -400 -400 4 8 8 0 30 0 30 20 20 20 state 25↑ 25↑ 25↑ 5↑ 5↑ 5↑

[↑]The arrow indicates that the rising edge of the clock pulse is used for reference.



SDLS090 - OCTOBER 1976 - REVISED MARCH 1988

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONST		SN54LS273			SN74LS273			UNIT	
	PARAMETER	TEST CONDITIONS!		MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIH	High-level input voltage				2			2			V
VIL	Low-level input voltage						0.7			0.8	V
VIK	Input clamp voltage	$V_{CC} = MIN,$	$I_{ } = -18 \text{ mA}$				-1.5			-1.5	V
Vон	High-level output voltage	V _{CC} = MIN, V _{IL} = V _{IL} max,	$V_{IH} = 2 V,$ $I_{OH} = -400$	μΑ	2.5	3.4		2.7	3.4		٧
V	Low-level output voltage	V _{CC} = MIN,	V _{IH} = 2 V,	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	V
VOL	Low-level output voltage	$V_{IL} = V_{IL} max$		$I_{OL} = 8 \text{ mA}$					0.35	0.5	V
II	Input current at maximum input voltage	V _{CC} = MAX,	V _I = 7 V				0.1			0.1	mA
lн	High-level input current	$V_{CC} = MAX$,	V _I = 2.7 V				20			20	μΑ
I _{IL}	Low-level input current	$V_{CC} = MAX$,	V _I = 0.4 V				-0.4			-0.4	mA
los	Short-circuit output current§	V _{CC} = MAX			-20	43_	-100	-20		-100	mA
ICC	Supply current	$V_{CC} = MAX$,	See Note 2			17	27		17	27	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: With all outputs open and 4.5 V applied to all data and clear inputs, I_{CC} is measured after a momentary ground, then 4.5 V, is applied to clock.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}	Maximum clock frequency		30	40		MHz
tPHL	Propagation delay time, high-to-low-level output from clear	C _L = 15 pF,		18	27	ns
tPLH	Propagation delay time, low-to-high-level output from clock	$R_L = 2 k\Omega$, See Note 3		17	27	ns
tPHL	Propagation delay time, high-to-low-level output from clock			18	27	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.

[§] Not more than one output should be shorted at a time and duration of short circuit should not exceed one second.

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